MP7645B

Cl Fered Multiplying 1

Buffered Multiplying 12-Bit Digital-to-Analog Converter



FEATURES

- Greater than 2000 V ESD Protection
- Differential Linearity +1/2 LSB Tmin to Tmax
- Microprocessor Compatible
- Low Glitch Energy
- Gain Error Tempco (2 ppm/°C max)
- Low Sensitivity to Amplifier Offset

- Four Quadrant Multiplication
- Latch-Up Free
- TTL/5 V CMOS Compatible
- Guaranteed Monotonic

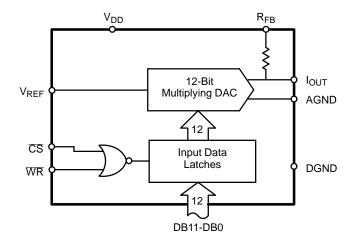
GENERAL DESCRIPTION

The MP7645B is an improved precision, monolithic 12-bit CMOS 4-quadrant multiplying DAC with an on-board data latch. The latch is loaded by a single 12-bit wide word. Data is loaded into the input latch under the control of $\overline{\text{CS}}$ and $\overline{\text{WR}}$ inputs. These control inputs are level triggered; tying these inputs low makes the input latch transparent allowing direct unbuffered operation of the DAC.

 Stability – The MP7645B incorporates a unique decoding technique yielding excellent accuracy and stability over temperature. Monotonicity is guaranteed over the entire temperature range including the industrial and military ranges. The gain error specification of 2 ppm/°C over a 100°C temperature range equals 0.8 LSB of error.

- Digital Feedthrough The MP7645B has 5 to 8 times less digital feedthrough than similar buffered DACs.
- Low Sensitivity to Output Amplifier Offset The additional linearity error incurred by amplifier offset is reduced by a factor of at least 3 in the MP7645B over conventional DACs. High latch-up resistance and high ESD protection make this a rugged, reliable attenuator!

SIMPLIFIED BLOCK DIAGRAM





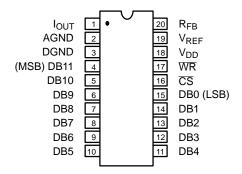


ORDERING INFORMATION

Package Type	Temperature Range	Part No.	INL (LSB)	DNL (LSB)	Gain Error (% FSR)
Plastic Dip	-40 to +85°C	MP7645BKN	<u>+</u> 1	<u>+</u> 1	<u>+</u> 0.2
Plastic Dip	–40 to +85°C	MP7645BLN	<u>+</u> 1/2	<u>+</u> 1/2	<u>+</u> 0.2
Ceramic Dip	−40 to +85°C	MP7645BBD	<u>+</u> 1	<u>+</u> 1	<u>+</u> 0.2
Ceramic Dip	–40 to +85°C	MP7645BCD	<u>+</u> 1/2	<u>+</u> 1/2	<u>+</u> 0.2

PIN CONFIGURATION

See Packaging Section for Package Dimensions



20 Pin CDIP, PDIP (0.300") D20, N20

PIN OUT DEFINITIONS

PIN NO.	NAME	DESCRIPTION
1	I _{OUT}	Current Output Port
2	AGND	Analog Ground
3	DGND	Digital Ground
4	DB11	Data Input Bit 11 (MSB)
5	DB10	Data Input Bit 10
6	DB9	Data Input Bit 9
7	DB8	Data Input Bit 8
8	DB7	Data Input Bit 7
9	DB6	Data Input Bit 6
10	DB5	Data Input Bit 5

PIN NO.	NAME	DESCRIPTION	
11	DB4	Data Input Bit 4	
12	DB3	Data Input Bit 3	
13	DB2	Data Input Bit 2	
14	DB1	Data Input Bit 1	
15	DB0	Data Input Bit 0 (LSB)	
16	CS	Chip Select Input (Active Low)	
17	WR	Write Input (Active Low)	
18	V _{DD}	Positive Voltage Power Supply	
19	V _{REF}	Reference Voltage Input	
20	R _{FB}	Feedback Resistor Input	

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ELECTRICAL CHARACTERISTICS

 $(V_{DD} = + 15 \text{ V}, V_{REF} = +10 \text{ V} \text{ unless otherwise noted})$

Parameter	Symbol	Min	25°C Typ	Max	Tmin to	Tmax Max	Units	Test Conditions/Comments
STATIC PERFORMANCE ¹	- Cymbol		176	- Mux		- IVIGA	Omio	FSR = Full Scale Range
								FOR = Full Scale Range
Resolution (All Grades)	N	12			12		Bits	
Integral Non-Linearity	INL						LSB	End Point Linearity
(Relative Accuracy) K, B				<u>+</u> 1		<u>+</u> 1		
L, C				<u>+</u> 1/2		<u>+</u> 1/2		
Differential Non-Linearity	DNL						LSB	
K, B L, C				<u>+</u> 1 <u>+</u> 1/2		<u>+</u> 1 <u>+</u> 1/2		
	0.5						o/ 50 5	
Gain Error K, B	GE			<u>+</u> 0.2		<u>+</u> 0.2	% FSR	Using Internal R _{FB}
L, C				<u>+</u> 0.2		<u>+</u> 0.2		
Gain Temperature Coefficient ²	TC _{GE}					<u>+</u> 2	ppm/°C	Δ Gain/ Δ Temperature
Monotonicity		Gı	uarantee	d	Guara	nteed		
K, L								12-Bit Monotonic Tmin to Tmax
Power Supply Rejection Ratio	PSRR			<u>+</u> 50		<u>+</u> 50	ppm/%	$ \Delta Gain/\Delta V_{DD} \Delta V_{DD} = \pm 5\%$
Output Leakage Current	l _{OUT}						nA	
K, L, B, C				<u>+</u> 10		<u>+</u> 200		
DYNAMIC PERFORMANCE ²								
Current Settling Time	t _S		1			2 typ	μs	Full Scale Change to 1/2 LSB
AC Feedthrough at I _{OUT} Propagation Delay	F _T		5 50			5	mV p-p ns	V _{REF} = 10kHz, 20 Vp-p, sinewave From digital input change to
Tropagation Bolay	1 40		00				110	90% of final value
REFERENCE INPUT								
Input Resistance	R _{IN}	7	11	25	7	25	kΩ	
DIGITAL INPUTS ³								
Logical "1" Voltage	V _{IH}	3			3.0		V	
Logical "0" Voltage	V_{IL}			+0.8		+0.8	V	
Input Leakage Current Input Capacitance ²	I _{LKG}			<u>+</u> 1		<u>+</u> 10	μΑ	
Data Control	C _{IN} C _{IN}			5 20		5 20	pF pF	DB0-DB11 WR, CS
	CIN			20		20	pr	WK, CS
ANALOG OUTPUTS								
Output Capacitance ²	C		50				pF	DAC Inputs all 0's
	C _{OUT}		100				pF pF	DAC Inputs all 1's



ELECTRICAL CHARACTERISTICS (CONT'D)

Parameter	Symbol	Min	25°C Typ	Max	Tmin to Min	Tmax Max	Units	Test Conditions/Comments
POWER SUPPLY								
Functional Voltage Range ⁵ Supply Current	V _{DD} I _{DD}	5		15 1	5	15 1	V mA	All digital inputs = 0 V or all = 5 V
SWITCHING CHARACTERISTICS ^{2, 4}								
Chip Select to Write Set-Up Time Chip Select to Write Hold Time Write Pulse Width Data Valid to Write Set-Up Time Data Valid to Write Hold Time	tcs tch twr tds tdh	180 0 100 100 10					ns ns ns ns ns	

NOTES:

- ¹ Full Scale Range (FSR) is 10V for unipolar mode.
- Guaranteed but not production tested.
- Digital input levels should not go below ground or exceed the positive supply voltage, otherwise damage may occur.
- See timing diagram.
- ⁵ Specified values guarantee functionality. Refer to other parameters for accuracy.

Specifications are subject to change without notice

ABSOLUTE MAXIMUM RATINGS (TA = +25°C unless otherwise noted)^{1, 2, 3}

V _{DD} to GND+17 V	Storage Temperature65°C to +150°C
Digital Input Voltage to GND (2) . GND -0.5 to V_{DD} +0.5 V	
I_{OUT1} , I_{OUT2} to GND GND -0.5 to V_{DD} +0.5 V	Lead Temperature (Soldering, 10 seconds) +300°C
V _{REF} to GND (2) <u>+</u> 25 V	Package Power Dissipation Rating to 75°C
V _{RFB} to GND (2) <u>+</u> 25 V	
AGND to DGND	CDIP, PDIP
(Functionality Guaranteed ±0.5 V)	Derates above 75°C 13mW/°C

NOTES:

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation at or above this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

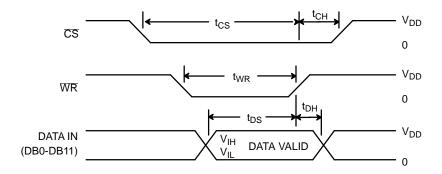
Any input pin which can see a value outside the absolute maximum ratings should be protected by Schottky diode clamps (HP5082-2835) from input pin to the supplies.

3 GND refers to AGND and DGND.





WRITE CYCLE TIMING DIAGRAM



APPLICATION NOTES Refer to Section 8 for Applications Information

MICROPROCESSOR INTERFACING OF THE MP7645B

The MP7645B can interface directly to both 8- and 16-bit microprocessors via its 12-bit wide data latch using standard $\overline{\text{CS}}$ and $\overline{\text{WR}}$ control signals.

A typical interface circuit for an 8-bit processor is shown (*Figure 1.*) This arrangement uses two memory addresses, one for the lower 8 bits of data to the DAC and one for the upper 4 bits of data into the DAC via the latch.

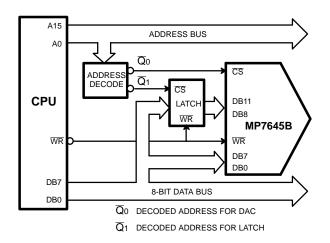


Figure 1. 8-Bit Processor to MP7645B Interface

Figure 2. shows an alternative approach for use with 8-bit processors which have a full 16-bit wide address bus such as 6800, 8080 and Z80. This technique uses the 12 lower address lines of the processor addresses bus to supply data to the DAC, thus each MP7645B connected in this way uses 4k bytes of address locations. Data is written to the DAC using a single memory write instruction. The address field of the instruction is organized so that the lower 12 bits contain the data for the DAC and the upper 4 bits contain the address of the 4k block at which the DAC resides.

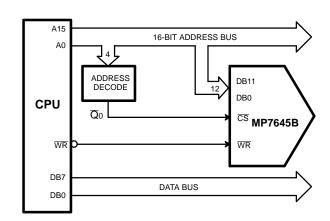
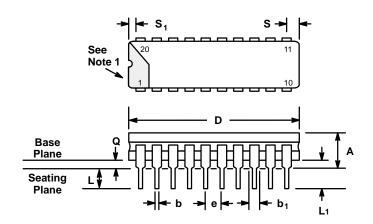


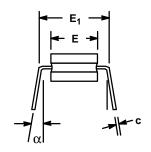
Figure 2. Connecting the MP7645B to 8-Bit Processors via the Address Bus





20 LEAD CERAMIC DUAL-IN-LINE (300 MIL CDIP) D20





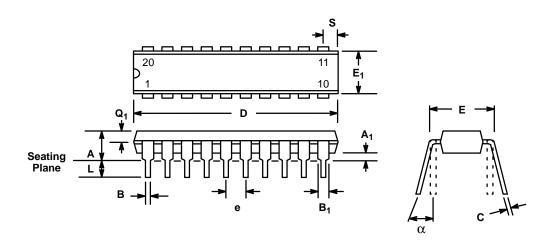
	INCHES		INCHES MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А		0.200		5.08	
b	0.014	0.023	0.356	0.584	_
b ₁	0.038	0.065	0.965	1.65	2
С	0.008	0.015	0.203	0.381	
D	_	1.060		26.92	4
Е	0.220	0.310	5.59	7.87	4
E ₁	0.290	0.320	7.37	8.13	7
е	0.10	00 BSC	2.5	4 BSC	5
L	0.125	0.200	3.18	5.08	_
L ₁	0.150	_	3.81	_	_
Q	0.015	0.070	0.381	1.78	3
S	_	0.080	_	2.03	6
S ₁	0.005	_	0.13	_	6
α	0°	15°	0°	15°	_

NOTES

- Index area; a notch or a lead one identification mark is located adjacent to lead one and is within the shaded area shown.
- 2. The minimum limit for dimension b_1 may be 0.023 (0.58 mm) for all four corner leads only.
- 3. Dimension Q shall be measured from the seating plane to the base plane.
- 4. This dimension allows for off-center lid, meniscus and glass overrun.
- The basic lead spacing is 0.100 inch (2.54 mm) between centerlines.
- 6. Applies to all four corners.
- 7. This is measured to outside of lead, not center.



20 LEAD PLASTIC DUAL-IN-LINE (300 MIL PDIP) N20



	INC	HES	MILLIN	METERS
SYMBOL	MIN	MAX	MIN	MAX
А		0.200		5.08
A ₁	0.015	_	0.38	_
В	0.014	0.023	0.356	0.584
B ₁ (1)	0.038	0.065	0.965	1.65
С	0.008	0.015	0.203	0.381
D	0.945	1.060	24.0	26.92
Е	0.295	0.325	7.49	8.26
E ₁	0.220	0.310	5.59	7.87
е	0.10	00 BSC	2.5	4 BSC
L	0.115	0.150	2.92	3.81
α	0°	15°	0°	15°
Q ₁	0.055	0.070	1.40	1.78
S	0.040	0.080	1.02	2.03

Note: (1) The minimum limit for dimensions B1 may be 0.023" (0.58 mm) for all four corner leads only.



NOTICE

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